

<b>Notice of References Cited</b>	Application/Control No. 10/537,962		Applicant(s)/Patent Under Reexamination HAUBNER ET AL.	
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*	A	US-5,395,959	03-1995	Weyer et al.	560/231
	B	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1361243 A1	11-2003	European Patent	KODAMA et al.	
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition, or Volume, Pertinent Pages)
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